

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic Drain-Source Voltage			Symbol	Value	Unit
			V _{DSS}	60	V
Gate-Source Voltage		(Note 6)	V _{GS}	±20	V
Single Pulsed Avalanche Energy		(Note 13)	E _{AS}	37.5	mJ
Single Pulsed Avalanche Current		(Note 13)	AS	5.0	А
Continuous Drain Current	V _{GS} = 10V	(Note 8)		4.4	
		T _A = +70°C (Note 8)	ID	3.5	А
		(Note 7)		3.3	
Pulsed Drain Current	$V_{GS} = 10V$	(Note 9)	I _{DM}	17.0	А
Continuous Source Current (Body diode)		(Note 8)	ls	3.2	А
Pulsed Source Current (Body diode)		(Note 9)	I _{SM}	17.0	А

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
	(Notes 7 & 10)		1.25 10		
Power Dissipation Linear Derating Factor	(Notes 7 & 11)	PD	1.8 14.3	W mW/°C	
	(Notes 8 & 10)		2.14 17.2		
	(Notes 7 & 10)		100	°C/W	
Thermal Resistance, Junction to Ambient	(Notes 7 & 11)	R _{AJA}	70		
	(Notes 8 & 10)		58		
Thermal Resistance, Junction to Lead	(Notes 10 & 12)	$R_{ ext{ heta}JL}$	55		
Operating and Storage Temperature Range	TJ, TSTG	-55 to 150	°C		

Notes: 6. AEC-Q101 V_{GS} maximum is $\pm 16V.$

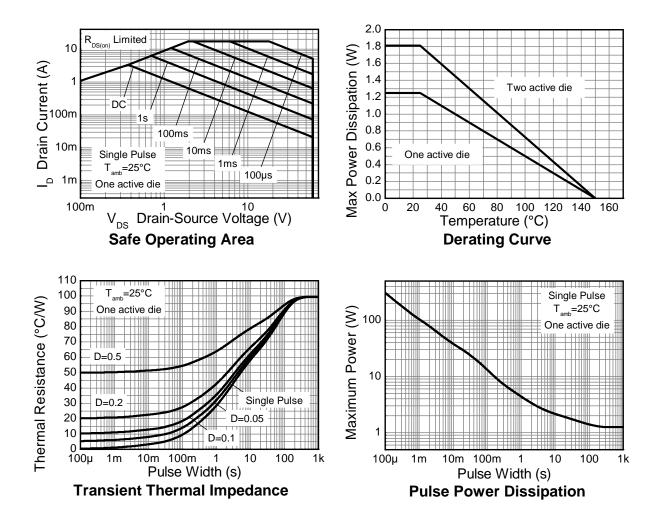
7. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is

The for a device surface mounted on 25mm x 25mm x 15mm FK4 PCB with high coverage of single sided 102 copper, in still all conditions, the device is measured when operating in a steady-state condition. 8. Same as note (3), except the device is measured at t \leq 10 sec. 9. Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature. 10. For a dual device with one active die.

 $\begin{array}{l} \mbox{11. For a device with two active die running at equal power.} \\ \mbox{12. Thermal resistance from junction to solder-point (at the end of the drain lead).} \\ \mbox{13. UIS in production with L = 3.0mH, I_{AS} = 5.0A, R_G = 25\Omega, V_{DD} = 50V, starting T_J = +25^{\circ}C. \end{array}$



Thermal Characteristics





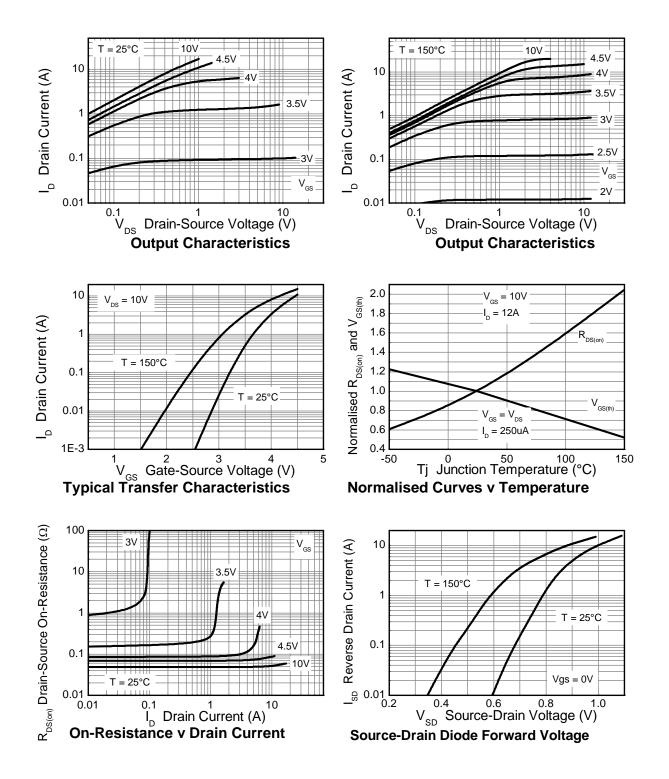
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test	Condition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	60			V	I _D = 250μA, V _{GS} = 0V	
Zero Gate Voltage Drain Current	I _{DSS}	_		0.5	μA	V _{DS} = 60V, V _{GS} = 0V	
Gate-Source Leakage	IGSS	_		±100	nA	V _{GS} = ±20V, V _{DS} = 0V	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	1.0		3.0	V	I _D = 250µA, V _{DS} = V _{GS}	
Statia Drain Source On Resistance (Note 14)		_	0.048	0.066	Ω	V _{GS} = 10V, I _D = 4.5A	
Static Drain-Source On-Resistance (Note 14)	R _{DS (ON)}		0.068	0.097		V _{GS} = 4.5V, I _D =	3.5A
Forward Transconductance (Notes 14 & 15)	g fs	_	19.2		S	V _{DS} = 15V, I _D = 6A	
Diode Forward Voltage (Note 14)	V _{SD}	_	0.89	1.15	V	I _S = 4.5A, V _{GS} = 0V	
Reverse recovery time (Note 15)	t _{rr}		22.2		ns	−I _S = 1.9A, di/dt= 100A/µs	
Reverse recovery charge (Note 15)	Qrr	_	16.9		nC		
DYNAMIC CHARACTERISTICS (Note 15)							
Input Capacitance	Ciss	—	502		pF		
Output Capacitance	C _{oss}	_	45.7		pF	V _{DS} = 30V, V _{GS} = 0V f= 1MHz	= 0V
Reverse Transfer Capacitance	Crss	_	27.1		pF		
Total Gate Charge (Note 16)	Qg	_	5.4		nC	V _{GS} = 4.5V	
Total Gate Charge (Note 16)	Qg	_	10.3		nC	V _{DS} = 30V V _{GS} = 10V I _D = 4.5A	
Gate-Source Charge (Note 16)	Q _{gs}	_	1.7		nC		
Gate-Drain Charge (Note 16)	Q _{qd}	_	3.2		nC		
Turn-On Delay Time (Note 16)	t _{D(on)}		2.7		ns	V_{DD} = 30V, V_{GS} = 10V I_D = 1A, $R_G \cong 6.0\Omega$	
Turn-On Rise Time (Note 16)	tr	_	2.4		ns		
Turn-Off Delay Time (Note 16)	t _{D(off)}		14.7		ns		
Turn-Off Fall Time (Note 16)	t _f	_	5.4		ns		

 Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%.
 For design aid only, not subject to production testing.
 Switching characteristics are independent of operating junction temperatures. Notes:

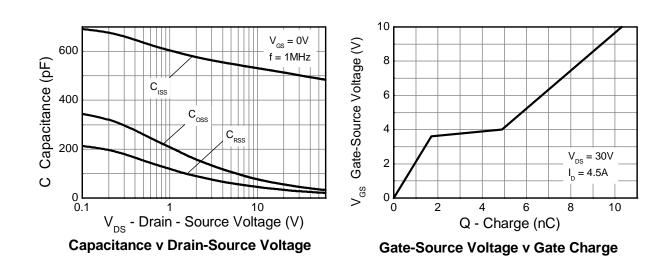


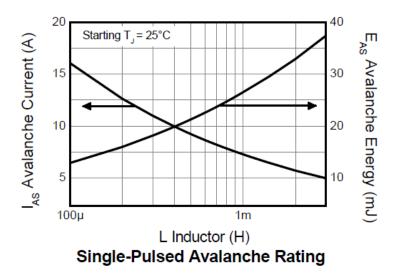
Typical Characteristics



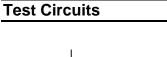


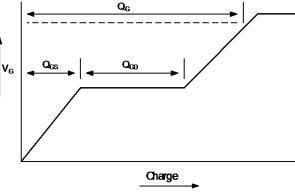
Typical Characteristics (continued)

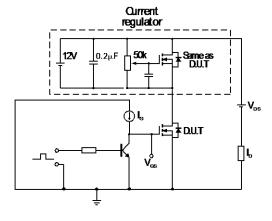






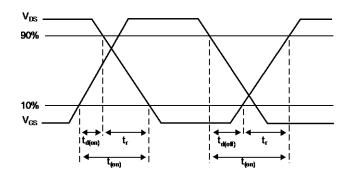




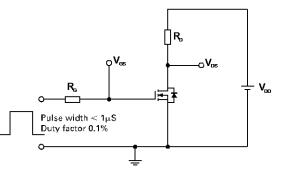


Basic gate charge waveform





Switching time waveforms

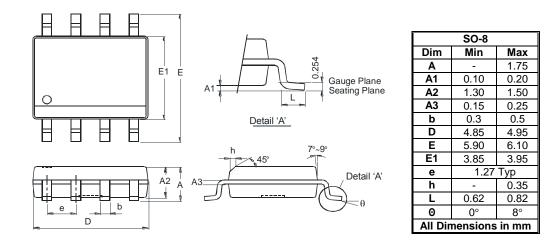


Switching time test circuit



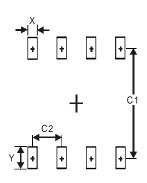
Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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